

March 1997

CMOS Octal Latching Bus Driver

Features

- Full Eight-Bit Parallel Latching Buffer
- Bipolar 8282 Compatible
- Three-State Noninverting Outputs
- Propagation Delay 35ns Max.
- Gated Inputs:
 - Reduce Operating Power
 - Eliminate the Need for Pull-Up Resistors
- Single 5V Power Supply
- Low Power Operation ICCSB = 10 μ A
- Operating Temperature Ranges
 - C82C82 0°C to +70°C
 - I82C82 -40°C to +85°C
 - M82C82 -55°C to +125°C

Description

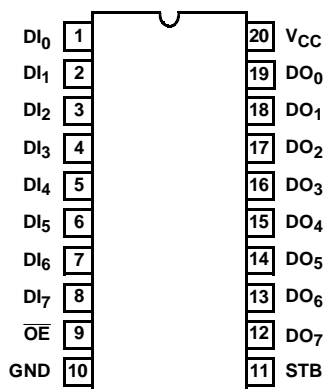
The Intersil 82C82 is a high performance CMOS Octal Latching Buffer manufactured using a self-aligned silicon gate CMOS process (Scaled SAJI IV). The 82C82 provides an eight-bit parallel latch/buffer in a 20 pin package. The active high strobe (STB) input allows transparent transfer of data and latches data on the negative transition of this signal. The active low output enable (\overline{OE}) permits simple interface to state-of-the-art microprocessor systems.

Ordering Information

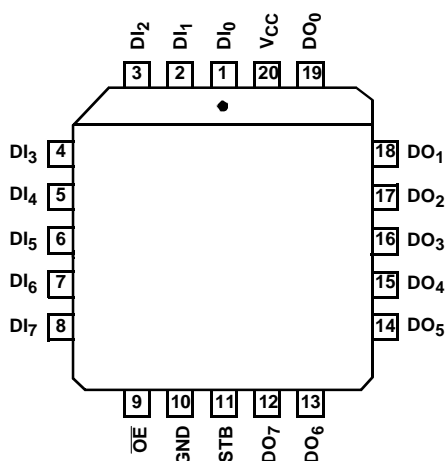
PART NUMBER	TEMP. RANGE	PACKAGE	PKG. NO.
CP82C82	0°C to +70°C	20 Ld PDIP	E20.3
IP82C82	-40°C to +85°C		
CS82C82	0°C to +70°C	20 Ld PLCC	N20.35
IS82C82	-40°C to +85°C		
CD82C82	0°C to +70°C	20 Ld CERDIP	F20.3
ID82C82	-40°C to +85°C		
MD82C82/B	-55°C to +125°C		
8406701RA		SMD #	
MR82C82/B	-55°C to +125°C	20 Pad CLCC	J20.A
84067012A		SMD #	

Pinouts

82C82 (PDIP, CERDIP)
TOP VIEW



82C82 (PLCC, CLCC)
TOP VIEW



TRUTH TABLE

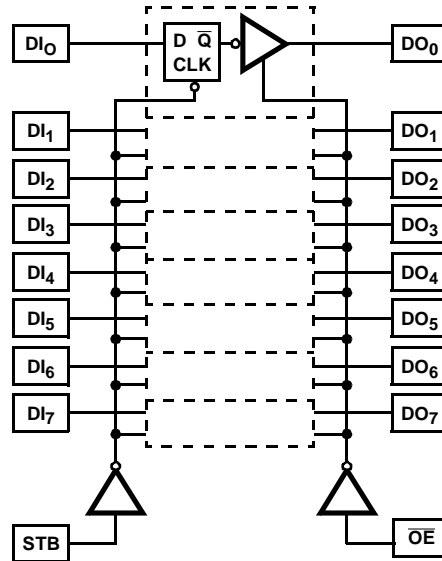
STB	\overline{OE}	DI	DO
X	H	X	Hi-Z
H	L	L	L
H	L	H	H
↓	L	X	†

H = Logic One
 L = Logic Zero
 X = Don't Care
 † = Latched to Value of Last Data
 Hi-Z = High Impedance
 ↓ = Neg. Transition

PIN NAMES

PIN	DESCRIPTION
DI ₀ -DI ₇	Data Input Pins
DO ₀ -DO ₇	Data Output Pins
STB	Active High Strobe
\overline{OE}	Active Low Output Enable

Functional Diagram



Gated Inputs

During normal system operation of a latch, signals on the bus at the device inputs will become high impedance or make transitions unrelated to the operation of the latch. These unrelated input transitions switch the input circuitry and typically cause an increase in power dissipation in CMOS devices by creating a low resistance path between V_{CC} and GND when the signal is at or near the input switching threshold. Additionally, if the driving signal becomes high impedance ("float" condition), it could create an indeterminate logic state at the input and cause a disruption in device operation.

The Intersil 82C8X Series of bus drivers eliminates these conditions by turning off data inputs when data is latched (STB = logic zero for the 82C82/83H) and when the device is disabled (OE = logic one for 82C86H/87H). These gated inputs disconnect the input circuitry from the V_{CC} and ground power supply pins by turning off the upper P-channel and lower N-channel (see Figures 1, 2). No new current flow from V_{CC} to GND occurs during input transitions and invalid logic states from floating inputs are not transmitted. The next stage is held

to a valid logic level internal to the device.

DC input voltage levels can also cause an increase in ICC if these input levels approach the minimum V_{IH} or maximum V_{IL} conditions. This is due to the operation of the input circuitry in its linear operating region (partially conducting state). The 82C8X series gated inputs mean that this condition will occur only during the time the device is in the transparent mode (STB = logic one). ICC remains below the maximum ICC standby specification of 10mA during the time inputs are disabled, thereby, greatly reducing the average power dissipation of the 82C8X series devices

Typical 82C82 System Example

In a typical 80C86/88 system, the 82C82 is used to latch multiplexed addresses and the STB input is driven by ALE (Address Latch Enable) (see Figure 3). The high pulse width of ALE is approximately 100ns with a bus cycle time of 800ns (80C86/88 at 5MHz). The 82C82 inputs are active only 12.5% of the bus cycle time. Average power dissipation

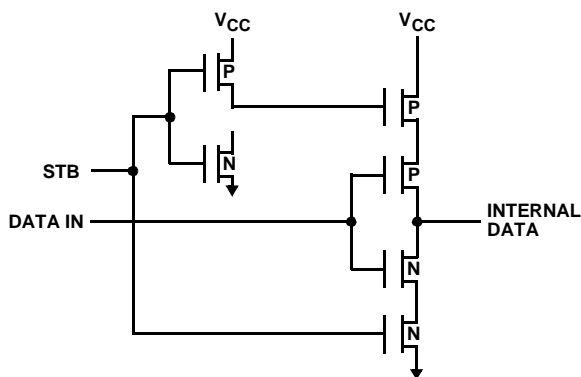


FIGURE 16. 82C82/83H

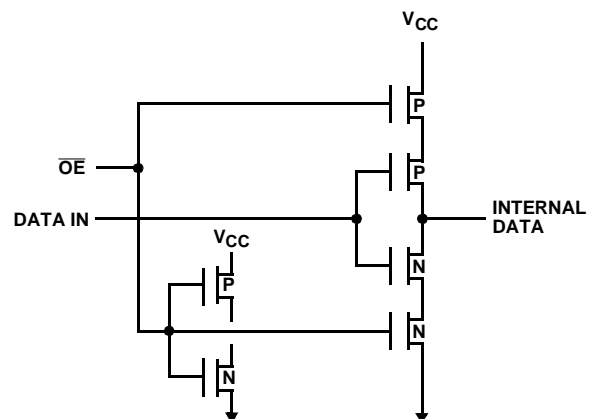


FIGURE 17. 82C86H/87H GATED INPUTS

Application Information

Decoupling Capacitors

The transient current required to charge and discharge the 300pF load capacitance specified in the 82C82 data sheet is determined by:

$$I = C_L (dv/dt) \quad (\text{EQ. 1})$$

Assuming that all outputs change state at the same time and

that dv/dt is constant;

$$I = C_L \quad (\text{EQ. 2})$$

$$\frac{(V_{CC} \times 80\%)}{tR/tF} \quad (\text{EQ. 3})$$

where $tR = 20\text{ns}$, $V_{CC} = 5.0\text{V}$, $C_L = 300\text{pF}$ on each of eight outputs.

$$I = (8 \times 300 \times 10^{-12}) \times (5.0\text{V} \times 0.8) / (20 \times 10^{-9}) = 480\text{mA} \quad (\text{EQ. 4})$$

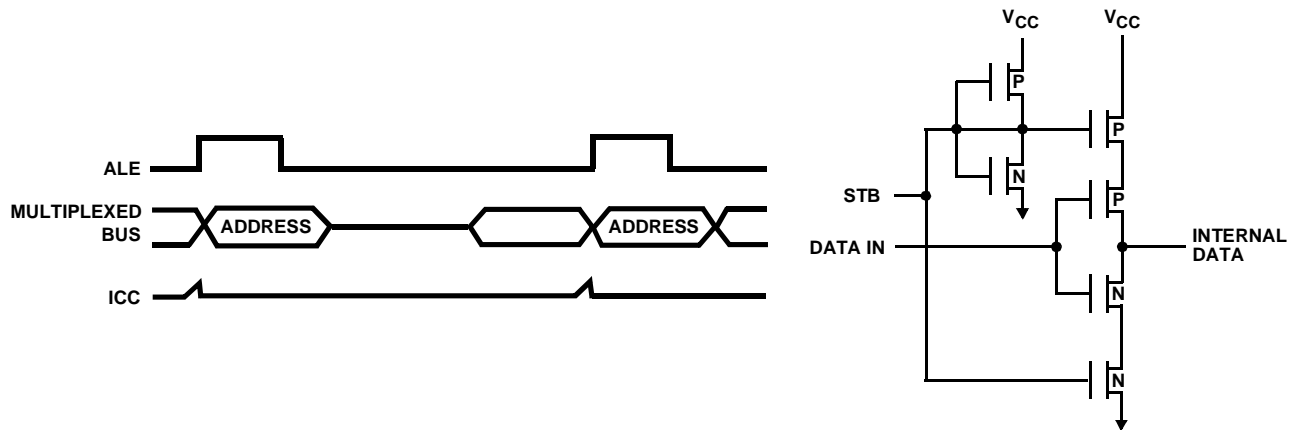


FIGURE 18. SYSTEM EFFECTS OF GATED INPUTS

Absolute Maximum Ratings

Thermal Information

82C82

Supply Voltage +8.0V
 Input, Output or I/O Voltage GND-0.5V to $V_{CC} + 0.5V$
 ESD Classification Class 1

Operating Conditions

Operating Voltage Range +4.5V to +5.5V
 Operating Temperature Range
 C82C82 0°C to +70°C
 I82C82 -40°C to +85°C
 M82C82 -55°C to +125°C

Thermal Resistance (Typical)

	θ_{JA}	θ_{JC}
CERDIP	75°C/W	18°C/W
CLCC	85°C/W	22°C/W
PDIP	75	N/A
PLCC	75	N/A

Storage Temperature Range -65°C to +150°C

Maximum Junction Temperature

 Ceramic Package +175°C

 Plastic Package +150°C

Minimum Lead Temperature (Soldering 10s) +300°C
 (PLCC Lead Tips Only)

Die Characteristics

Gate Count 65 Gates

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

DC Electrical Specifications $V_{CC} = 5.0V \pm 10\%$;

$T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$ (C82C82);

$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$ (I82C82);

$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$ (M82C82)

SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
V_{IH}	Logical One Input Voltage	2.0	-	V	C82C82, I82C82 (Note 1)
		2.2	-	V	M82C82 (Note 1)
V_{IL}	Logical Zero Input Voltage	-	0.8	V	
V_{OH}	Logical One Output Voltage	2.9	-	V	$I_{OH} = -8\text{mA}$, $\overline{OE} = \text{GND}$
		$V_{CC} - 0.4V$	-	V	$I_{OH} = -100\mu\text{A}$, $\overline{OE} = \text{GND}$
V_{OL}	Logical Zero Output Voltage	-	0.4	V	$I_{OL} = 8\text{mA}$, $\overline{OE} = \text{GND}$
II	Input Leakage Current	-1.0	1.0	μA	$V_{IN} = \text{GND}$ or V_{CC} , DIP Pins 1-9, 11
IO	Output Leakage Current	-10.0	10.0	μA	$V_O = \text{GND}$ or V_{CC} , $\overline{OE} \geq V_{CC} - 0.5V$ DIP Pins 12-19
ICCSB	Standby Power Supply Current	-	10	μA	$V_{IN} = V_{CC}$ or GND, $V_{CC} = 5.5V$, Outputs Open
ICCOP	Operating Power Supply Current	-	1	mA/MHz	$T_A = +25^\circ\text{C}$, $V_{CC} = 5V$, Typical (See Note 2)

NOTES:

- V_{IH} is measured by applying a pulse of magnitude = V_{IH} min to one data input at a time and checking the corresponding device output for a valid logical "1" during valid input high time. Control pins (STB, \overline{OE}) are tested separately with all device data input pins at $V_{CC} - 0.4V$.
- Typical ICCOP = 1mA/MHz of STB cycle time. (Example: 5MHz μP , ALE = 1.25MHz, ICCOP = 1.25mA).

Capacitance $T_A = +25^\circ\text{C}$

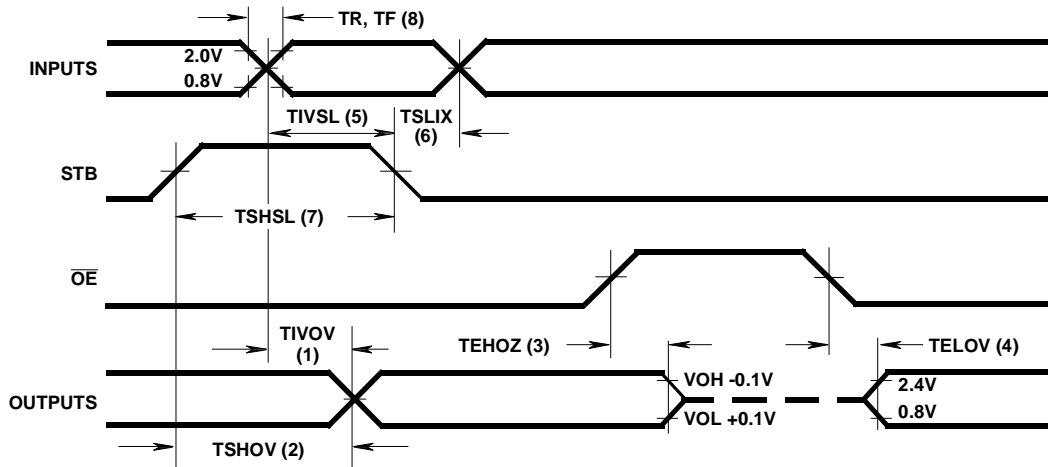
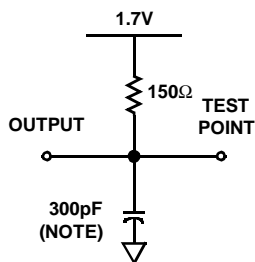
SYMBOL	PARAMETER	TYPICAL	UNITS	TEST CONDITIONS
C_{IN}	Input Capacitance	13	pF	Freq = 1MHz, all measurements are referenced to device GND
C_{OUT}	Output Capacitance	20	pF	

AC Electrical Specifications $V_{CC} = 5.0V \pm 10\%$; $T_A = 0^{\circ}C$ to $+70^{\circ}C$ (C82C82); $C_L = 300pF$ (Note 1), Freq = 1MHz $T_A = -40^{\circ}C$ to $+85^{\circ}C$ (I82C82); $T_A = -55^{\circ}C$ to $+125^{\circ}C$ (M82C82)

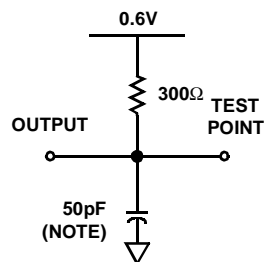
SYMBOL	PARAMETER	MIN	MAX	UNITS	TEST CONDITIONS
(1) TIOV	Propagation Delay Input to Output	-	35	ns	Notes 2, 3
(2) TSHOV	Propagation Delay STB to Output	-	55	ns	Notes 2, 3
(3) TEHOZ	Output Disable Time	-	35	ns	Notes 2, 3
(4) TELOV	Output Enable Time	-	50	ns	Notes 2, 3
(5) TIVSL	Input to STB Setup Time	0	-	ns	Notes 2, 3
(6) TSLIX	Input to STB Hold Time	25	-	ns	Notes 2, 3
(7) TSHSL	STB High Time	25	-	ns	Notes 2, 3
(8) TR, TF	Input Rise/Fall Times	-	20	ns	Notes 2, 3

NOTES:

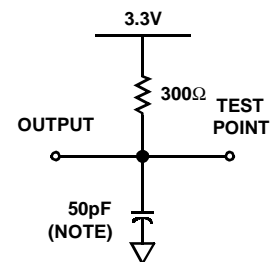
- Output load capacitance is rated at 300pF for ceramic and plastic packages.
- All AC parameters tested as per test circuits and definitions below. Input rise and fall times are driven at 1ns/V.
- Input test signals must switch between $V_{IL} - 0.4V$ and $V_{IH} + 0.4V$.

Timing Waveforms**Test Load Circuits**

TIOV, TSHOV, TELOV



TEHOZ OUTPUT HIGH DISABLE

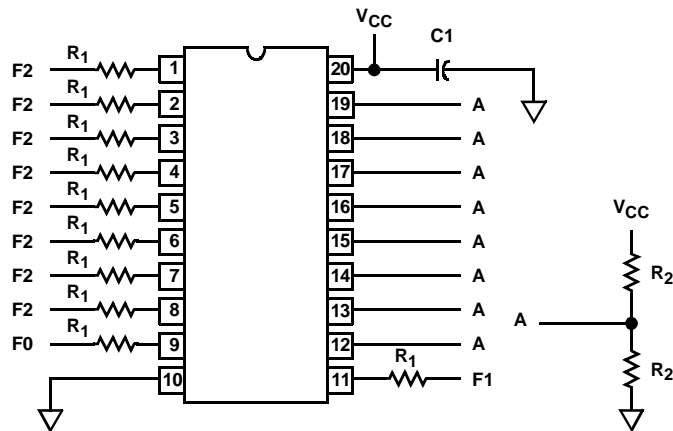


TEHOZ OUTPUT LOW DISABLE

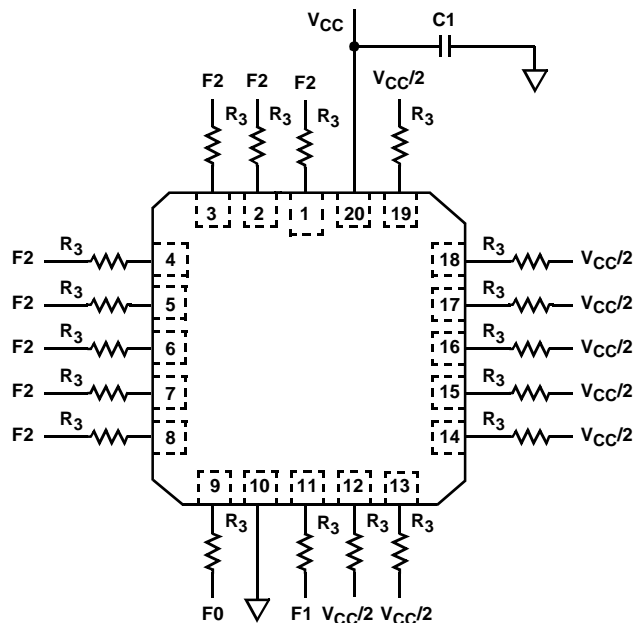
NOTE: Includes stray and jig capacitance.

Burn-In Circuits

MD82C82 Cerdip



MR82C82 CLCC



NOTES:

1. $V_{CC} = 5.5 \pm 0.5V$, $GND = 0V$.
2. $V_{IH} = 4.5V \pm 10\%$.
3. $V_{IL} = -0.2V$ to $0.4V$.
4. $R_1 = 47k\Omega \pm 5\%$.
5. $R_2 = 2.0k\Omega \pm 5\%$.
6. $R_3 = 4.2k\Omega \pm 5\%$.
7. $R_4 = 470k\Omega \pm 5\%$.
8. $C_1 = 0.01\mu F$ minimum.
9. $F_0 = 100kHz \pm 10\%$.
10. $F_1 = F_0/2$, $F_2 = F_1/2$.

82C82

Die Characteristics

DIE DIMENSIONS:

118.1 x 92.1 x 19 ±1mils

METALLIZATION:

Type: Si - Al

Thickness: 11kÅ ±1kÅ

GLASSIVATION:

Type: SiO₂

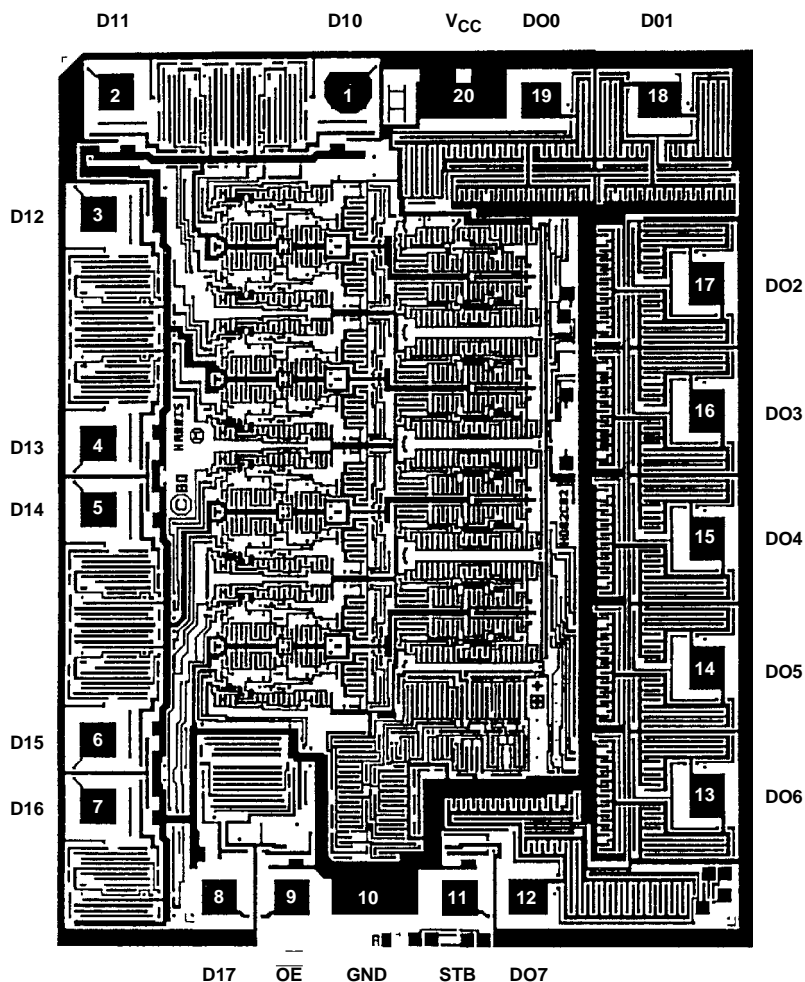
Thickness: 8kÅ ±1kÅ

WORST CASE CURRENT DENSITY:

2.00 x 10⁵ A/cm²

Metallization Mask Layout

82C82



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